

O-1449

U.S. DEPARTMENT OF  
COMMERCE  
PATENT AND TRADEMARK  
OFFICE

ATTY. DOCKET NO.  
45532/1:7

APPLICATION NO.  
10/053.483

-80)

APPLICANT  
Ronald A. Palfenier et al.

INFORMATION DISCLOSURE CITATION  
(Use several sheets if necessary)

FILING DATE  
November 2, 2001

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DF	AA	6 0 0 7 2 4 1	Dec 1999	Yam et al.	374	131	
DF	AB	5 8 9 7 6 1 0	Apr 1999	Jensen	702	134	
DF	AC	5 8 1 5 4 1 0	Sep 1998	Heinke et al.	364	557	
DF	AD	5 7 1 7 6 0 8	Feb 1998	Jensen	364	557	
DF	AE	5 7 0 4 7 1 2	Jan 1998	Stein	374	126	
DF	AF	5 6 9 0 4 2 9	Nov 1997	Ng	374	1	
DF	AG	5 1 5 4 5 1 2	Oct 1992	Scheitinger et al.	374	9	
DF	AH	4 9 5 6 5 3 8	Sep 1990	Moslehi	219	121.6	
DF	AI	4 8 4 5 6 4 7	Jul 1989	Dils et al.	364	557	
DF	AJ	4 7 5 0 1 3 9	Jun 1988	Dils	364	557	
DF	AK	4 5 7 4 4 8 6	Mar 1986	Dils	374	131	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

DF	AR	"Optical Pyrometry Begins to Fulfill its Promise," Alexander Braun, Semiconductor International, March 1998, pp. 1 and 2.
DF	AS	"A New Detector for IRLED Light," Russ Dahl and Michael Allen, reprinted from SENSORS Magazine, December 1996, 4 pp.
	AT	

EXAMINER

Dimitri Palfenier

DATE CONSIDERED 12/10/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation  
not in conformance.

O-1449

-80)

U.S. DEPARTMENT OF  
COMMERCE  
PATENT AND TRADEMARK  
OFFICE

ATTY. DOCKET NO.  
45532/1:7

APPLICATION NO.  
10/053,483

APPLICANT

Ronald A. Palfenier et al.

INFORMATION DISCLOSURE CITATION  
(Use several sheets if necessary)

FILING DATE

November 2, 2001

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DP	AA	4	3	4	8	1	1	0		Sep 1982	Ito	356	328	
DP	AB	4	0	7	5	4	9	3		Feb 1978	Wickersheim	250	461 R	
DP	AC	3	6	2	6	7	5	8		Dec 1971	Stewart et al.	73	355R	
DP	AD	2	7	0	9	3	6	7		May 1955	Bohnet	73	355	
DP	AE	1	6	3	9	5	3	4		Aug 1927	Ruben			
DP	AF	1	4	7	5	3	6	5		Nov 1923	Schueler et al.			
	AG													
	AH													
	AI													
	AJ													
	AK													

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
														YES	NO
	AL														
	AM														
	AN														
	AO														
	AP														

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	
	AS	
	AT	

EXAMINER

Dennis R. H. H.

DATE CONSIDERED

12/10/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation if not in conformance and not considered.